

Search Notes**Application/Control No.**

10/747,737

Examiner

Emmanuel S. Luk

Applicant(s)/Patent under Reexamination

BAILEY ET AL.

Art Unit

1722

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 425 | 174.4 | 5/15/2006 | EL |
| 425 | 174 | 5/15/2006 | EL |
| 977 | 887 | 5/15/2006 | EL |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---------------------------------------|-----------|------|
| EAST text search | 5/15/2006 | EL |
| Application no. 09/976681, 09/907,512 | 5/15/2006 | EL |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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